

OPA2376AIYZDR Datasheet



https://www.DiGi-Electronics.com

DiGi Electronics Part Number OPA2376AIYZDR-DG

Manufacturer Texas Instruments

Manufacturer Product Number OPA2376AIYZDR

Description IC OPAMP GP 2 CIRCUIT 8DSBGA

Detailed Description General Purpose Amplifier 2 Circuit Single Ended, R

ail-to-Rail 8-DSBGA (2.15x1.11)



Tel: +00 852-30501935

RFQ Email: Info@DiGi-Electronics.com

DiGi is a global authorized distributor of electronic components.



Purchase and inquiry

Manufacturer Product Number:	Manufacturer:
OPA2376AIYZDR	Texas Instruments
Series:	Product Status:
	Active
Amplifier Type:	Number of Circuits:
General Purpose	2
Output Type:	Slew Rate:
Single Ended, Rail-to-Rail	2V/μs
Gain Bandwidth Product:	Current - Input Bias:
5.5 MHz	0.2 pA
Voltage - Input Offset:	Current - Supply:
5 μV	760μA (x2 Channels)
Current - Output / Channel:	Voltage - Supply Span (Min):
50 mA	2.2 V
Voltage - Supply Span (Max):	Operating Temperature:
5.5 V	-40°C ~ 125°C
Mounting Type:	Package / Case:
Surface Mount	8-XFBGA, DSBGA
Supplier Device Package:	Base Product Number:
8-DSBGA (2.15x1.11)	OPA2376

Environmental & Export classification

RoHS Status:	Moisture Sensitivity Level (MSL):
ROHS3 Compliant	1 (Unlimited)
REACH Status:	ECCN:
REACH Unaffected	EAR99
HTSUS:	

8542.33.0001











SBOS406G -JUNE 2007-REVISED DECEMBER 2015

OPAx376 Low-Noise, Low Quiescent Current, Precision Operational Amplifier e-trim Series

Features

Low Noise: 7.5 nV/√Hz at 1 kHz 0.1 Hz to 10 Hz Noise: 0.8 µV_{PP} Quiescent Current: 760 µA (typical)

Low Offset Voltage: 5 µV (typ) Gain Bandwidth Product: 5.5 MHz

Rail-to-Rail Input and Output Single-Supply Operation

Supply Voltage: 2.2 V to 5.5 V

Space-Saving Packages:

SC70, SOT-23, DSBGA, VSSOP, TSSOP

Applications

- **ADC Buffer**
- Audio Equipment
- Medical Instrumentation
- Handheld Test Equipment
- Active Filtering
- Sensor Signal Conditioning

3 Description

The OPA376 family represents a new generation of low-noise operational amplifiers with e-trim™, offering outstanding dc precision and ac performance. Rail-torail input and output, low offset (25 µV, maximum), low noise (7.5 nV/√Hz), quiescent current of 950 μA (maximum), and a 5.5-MHz bandwidth make this part very attractive for a variety of precision and portable applications. In addition, this device has a reasonably wide supply range with excellent PSRR, making it attractive for applications that run directly from batteries without regulation.

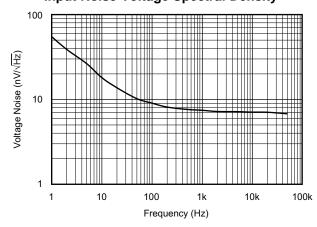
The OPA376 (single version) is available in SC70-5, **MicroSIZE** SOT-23-5, and SOIC-8 packages. The OPA2376 (dual) is offered in the DSBGA-8, VSSOP-8, and SOIC-8 packages. The OPA4376 (quad) is offered in a TSSOP-14 package. All versions are specified for operation from -40°C to +125°C.

Device Information⁽¹⁾

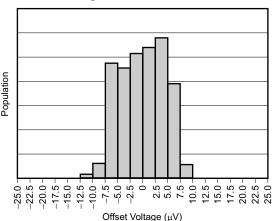
PART NUMBER	PACKAGE	BODY SIZE (NOM)	
	SOIC (8)	4.90 mm × 3.91 mm	
OPA376	SOT-23 (5)	2.90 mm × 1.60 mm	
	SC70 (5)	2.00 mm × 1.25 mm	
	SOIC (8)	4.90 mm × 3.91 mm	
OPA2376	VSSOP (8)	3.00 mm × 3.00 mm	
	DSBGA (8)	1.30 mm × 2.30 mm	
OPA4376	TSSOP (14)	5.00 mm × 4.40 mm	

(1) For all available packages, see the package option addendum at the end of the data sheet.

Input Noise Voltage Spectral Density



Offset Voltage Production Distribution





www.ti.com

Table of Contents

2Applications18Application and Implementation3Description18.1 Application Information4Revision History28.2 Typical Application5Pin Configuration and Functions39Power Supply Recommendations6Specifications610.1 Layout Guidelines6.1 Absolute Maximum Ratings610.1 Layout Guidelines6.2 ESD Ratings610.2 Layout Example6.3 Recommended Operating Conditions611Device and Documentation Support6.4 Thermal Information: OPA376711.1 Device Support6.5 Thermal Information: OPA4376711.2 Related Documentation6.6 Thermal Information: OPA4376711.3 Related Links6.7 Electrical Characteristics811.4 Community Resources6.8 Typical Characteristics1011.5 Trademarks7 Detailed Description1411.6 Electrostatic Discharge Caution7.1 Overview1411.7 Glossary7.2 Functional Block Diagram1412Mechanical, Packaging, and Orderable Information	16
3 Description 1 8.1 Application Information 4 Revision History 2 8.2 Typical Application 5 Pin Configuration and Functions 3 9 Power Supply Recommendations 6 Specifications 6 10 Layout 6.1 Absolute Maximum Ratings 6 10.1 Layout Guidelines 6.2 ESD Ratings 6 10.2 Layout Example 6.3 Recommended Operating Conditions 6 11 Device and Documentation Support 6.4 Thermal Information: OPA376 7 11.1 Device Support 6.5 Thermal Information: OPA2376 7 11.2 Related Documentation 6.6 Thermal Information: OPA4376 7 11.3 Related Links 6.8 Typical Characteristics 8 11.4 Community Resources 6.8 Typical Characteristics 10 11.5 Trademarks 7 Detailed Description 14 11.6 Electrostatic Discharge Caution 7.1 Overview 14 11.7 Glossary 7.2 Functional Block Diagram 14 12 Mechanical, Packaging, and Orderable	17
4 Revision History 2 8.2 Typical Application 5 Pin Configuration and Functions 3 9 Power Supply Recommendations 6 Specifications 6 10 Layout 6.1 Absolute Maximum Ratings 6 10.1 Layout Guidelines 6.2 ESD Ratings 6 10.2 Layout Example 6.3 Recommended Operating Conditions 6 11 Device and Documentation Support 6.4 Thermal Information: OPA376 7 11.1 Device Support 6.5 Thermal Information: OPA4376 7 11.2 Related Documentation 6.7 Electrical Characteristics 8 11.4 Community Resources 6.8 Typical Characteristics 10 11.5 Trademarks 7 Detailed Description 14 11.6 Electrostatic Discharge Caution 7.1 Overview 14 11.7 Glossary 7.2 Functional Block Diagram 14 12 Mechanical, Packaging, and Orderable	
5Pin Configuration and Functions39Power Supply Recommendations6Specifications610Layout6.1Absolute Maximum Ratings610.1Layout Guidelines6.2ESD Ratings610.2Layout Example6.3Recommended Operating Conditions611Device and Documentation Support6.4Thermal Information: OPA376711.1Device Support6.5Thermal Information: OPA4376711.2Related Documentation6.6Thermal Information: OPA4376711.3Related Links6.7Electrical Characteristics811.4Community Resources6.8Typical Characteristics1011.5Trademarks7Detailed Description1411.6Electrostatic Discharge Caution7Detailed Description1411.7Glossary7.1Overview1411.7Glossary7.2Functional Block Diagram14Mechanical, Packaging, and Orderable	<u>2</u> 0
6 Specifications 6 Layout 6.1 Absolute Maximum Ratings 6 6.2 ESD Ratings 6 6.3 Recommended Operating Conditions 6 6.4 Thermal Information: OPA376 7 6.5 Thermal Information: OPA2376 7 6.6 Thermal Information: OPA4376 7 6.7 Electrical Characteristics 8 6.8 Typical Characteristics 8 6.8 Typical Characteristics 10 7 Detailed Description 14 7.1 Overview 14 7.2 Functional Block Diagram 14 7.2 Functional Block Diagram 14 12 Mechanical, Packaging, and Orderable	21
6.1 Absolute Maximum Ratings 6 6.2 ESD Ratings 6 6.3 Recommended Operating Conditions 6 6.4 Thermal Information: OPA376 7 6.5 Thermal Information: OPA2376 7 6.6 Thermal Information: OPA4376 7 6.7 Electrical Characteristics 8 6.8 Typical Characteristics 8 6.8 Typical Characteristics 10 7 Detailed Description 14 7.1 Overview 14 7.2 Functional Block Diagram 14 12 Mechanical, Packaging, and Orderable	21
6.2 ESD Ratings	21
6.3 Recommended Operating Conditions 6 6.4 Thermal Information: OPA376 7 6.5 Thermal Information: OPA2376 7 6.6 Thermal Information: OPA4376 7 6.7 Electrical Characteristics 8 6.8 Typical Characteristics 10 7 Detailed Description 14 7.1 Overview 14 7.2 Functional Block Diagram 14 11 Device and Documentation Support 11.1 Device Support 11.2 Related Documentation 11.1 Device Support 11.2 Related Documentation 11.2 Related Links 11.3 Related Links 11.3 Related Links 11.3 Related Links 11.4 Community Resources 11.4 Community Resources 11.5 Trademarks 11.6 Electrostatic Discharge Caution 11.7 Glossary	22
6.4 Thermal Information: OPA376 7 11.1 Device Support	23
6.5 Thermal Information: OPA2376 7 11.2 Related Documentation 6.6 Thermal Information: OPA4376 7 11.3 Related Links 6.7 Electrical Characteristics 8 11.4 Community Resources 6.8 Typical Characteristics 10 11.5 Trademarks 7 Detailed Description 14 11.6 Electrostatic Discharge Caution 7.1 Overview 14 11.7 Glossary 7.2 Functional Block Diagram 14 12 Mechanical, Packaging, and Orderable	23
6.7 Electrical Characteristics 8 11.4 Community Resources 6.8 Typical Characteristics 10 11.5 Trademarks 7 Detailed Description 14 11.6 Electrostatic Discharge Caution 7.1 Overview 14 11.7 Glossary 7.2 Functional Block Diagram 14 12 Mechanical, Packaging, and Orderable	23
6.8 Typical Characteristics 10 11.5 Trademarks 11.6 Electrostatic Discharge Caution 11.7 Glossary 11	24
7 Detailed Description	24
7.1 Overview 14 11.7 Glossary	<u>2</u> 4
7.1 Overview	24
7.2 Functional Block Diagram	<u>2</u> 4
7.3 Feature Description 14 Information	
7.0 1 Gataro Doscription	25

4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision F (March 2013) to Revision G	Page
 Added ESD Ratings, Thermal Information, Recommended Operating Conditions, Power Su and Device and Documentation Support sections; existing sections may have moved 	
Changed WCSP to DSBGA and MSOP to VSSOP throughout data sheet	1
Changed dimensions shown in YZD package pinout figure	4
Changes from Revision E (January 2013) to Revision F	Page
Changed unit (typo) for Quiescent Current feature bullet	1
Changed TSSOP-14 pinout for OPA4376	5
Changes from Revision D (August 2010) to Revision E	Page
Changed rail-to-rail feature bullet to show input and output	1
Changed description text to show rail-to-rail input and output	1
Changes from Revision C (October 2008) to Revision D	Page
Updated format of <i>Electrical Characteristics</i> table	
Updated Figure 11	11

Submit Documentation Feedback

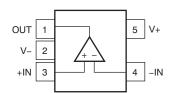
Copyright © 2007–2015, Texas Instruments Incorporated



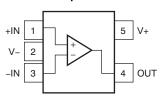
SBOS406G –JUNE 2007–REVISED DECEMBER 2015

5 Pin Configuration and Functions

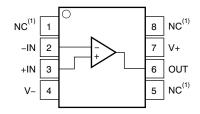
OPA376: DBV Package 5-Pin SOT23 Top View



OPA376: DCK Package 5-Pin SC70-5 Top View



OPA376: D Package 8-Pin SOIC Top View



(1) NC denotes no internal connection.

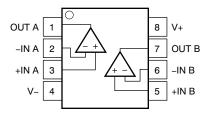
Pin Functions: OPA376

PIN				1/0	DESCRIPTION			
NAME	DBV	DCK	D	I/O	DESCRIPTION			
+IN	3	1	3	I	Input signal ⁺			
-IN	4	3	2	I	Input signal -			
NC	_	_	1, 5, 8	_	No connection			
OUT	1	4	6	0	Output signal			
V ⁺	5	5	7	_	Supply voltage ⁺			
V ⁻	2	2	4	_	Supply voltage			

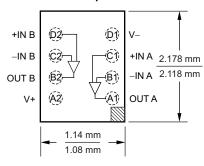
Copyright © 2007–2015, Texas Instruments Incorporated

INSTRUMENTS

OPA2376: D and DGK Packages 8-Pin SOIC and 8-Pin VSSOP Top View



OPA2376: YZD Package 8-Pin DSBGA Top View



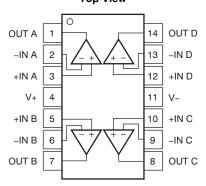
(Bump-Side Down)

Pin Functions: OPA2376

	PIN			
NAME	D AND DGK	YZD	I/O	DESCRIPTION
+IN A	3	C1	I	Input signal A ⁺
-IN A	2	B1	I	Input signal A ⁻
+IN B	5	D2	I	Input signal B ⁺
–IN B	6	C2	I	Input signal B ⁻
OUT A	1	A1	0	Output signal A
OUT B	7	B2	0	Output signal B
V ⁺	8	A2	_	Supply voltage ⁺
V ⁻	4	D1	_	Supply voltage



OPA4376: PW Package 14-Pin TSSOP Top View



Pin Functions: OPA4376

Р	PIN		DESCRIPTION					
NAME	PW	I/O	DESCRIPTION					
+IN A	3	I	Input signal A ⁺					
-IN A	2	0	Input signal A ⁻					
+IN B	5	I	Input signal B ⁺					
–IN B	6	0	Input signal B ⁻					
+IN C	10	I	Input signal C ⁺					
-IN C	9	0	Input signal C ⁻					
+IN D	12	I	Input signal D ⁺					
–IN D	13	0	Input signal D ⁻					
OUT A	1	0	Output signal A					
OUT B	7	0	Output signal B					
OUT C	8	0	Output signal C					
OUT D	14	0	Output signal D					
V ⁺	4	_	Supply voltage ⁺					
V ⁻	11	_	Supply voltage					

Copyright © 2007–2015, Texas Instruments Incorporated

www.ti.com

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
\/oltogo	Supply, $V_S = (V^+) - (V^-)$		7	V
Voltage	Signal input pin (2)	$(V^{-}) - 0.5$	$(V^+) + 0.5$	V
Current	Signal input pin (2)	-10	10	mA
	Output short-circuit ⁽³⁾		Continuous	
Temperature	Operating range, T _A	-40	150	
	Junction, T _J		150	°C
	Storage, T _{stq}	-65	150	

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings

			VALUE	UNIT
	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins $^{(1)}$	±4000		
V _(ESD)	Electrostatic discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins (2)	±1000	V
		Machine model	±200	

⁽¹⁾ JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

	· ·	<u> </u>	,			
				MIN	NOM MAX	UNIT
$(V^{+}) - (V^{-})$	Supply voltage			2.2 (±1.1)	5.5 (±2.75)	V
T _A	Operating temperature			-40	150	°C

⁽²⁾ Input terminals are diode-clamped to the power-supply rails. Input signals that can swing more than 0.5 V beyond the supply rails should be current limited to 10 mA or less.

⁽³⁾ Short-circuit to ground, one amplifier per package.

⁽²⁾ JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

SBOS406G -JUNE 2007-REVISED DECEMBER 2015

www.ti.com

6.4 Thermal Information: OPA376

			OPA376			
	THERMAL METRIC ⁽¹⁾	DBV (SOT-23)	DCK (SC70)	D (SOIC)	UNIT	
		5 PINS	5 PINS	8 PINS		
$R_{\theta JA}$	Junction-to-ambient thermal resistance	273.8	267.0	100.1	°C/W	
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	126.8	80.9	42.4	°C/W	
$R_{\theta JB}$	Junction-to-board thermal resistance	85.9	54.8	41.0	°C/W	
ΨЈТ	Junction-to-top characterization parameter	10.9	1.2	4.8	°C/W	
ΨЈВ	Junction-to-board characterization parameter	84.9	54.1	40.3	°C/W	
R _{0JC(bot)}	Junction-to-case (bottom) thermal resistance	n/a	n/a	n/a	°C/W	

For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

6.5 Thermal Information: OPA2376

	THERMAL METRIC ⁽¹⁾	D (SOIC)	DGK (VSSOP)	YZD (DSBGA)	UNIT
		8 PINS	8 PINS	8 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	111.1	171.2	119.2	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	54.7	63.9	0.6	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	51.7	92.8	27.6	°C/W
ΨЈТ	Junction-to-top characterization parameter	10.5	9.2	4.0	°C/W
ΨЈВ	Junction-to-board characterization parameter	51.2	91.2	27.6	°C/W
R ₀ JC(bot)	Junction-to-case (bottom) thermal resistance	n/a	n/a	n/a	°C/W

For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

6.6 Thermal Information: OPA4376

		OPA4376	
	THERMAL METRIC ⁽¹⁾	PW	UNIT
		14 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	107.8	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	29.6	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	52.6	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	1.5	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	51.6	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	n/a	°C/W

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

Product Folder Links: OPA376 OPA2376 OPA4376



SBOS406G - JUNE 2007-REVISED DECEMBER 2015

www.ti.com

6.7 Electrical Characteristics

At T_A = 25°C, R_L = 10 k Ω connected to V_S / 2, V_{CM} = V_S / 2, and V_{OUT} = V_S / 2, unless otherwise noted.

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFFSET V	OLTAGE					
Vos	Input offset voltage			5	25	μV
D/ /IT	Input offset voltage versus	$T_A = -40$ °C to +85°C		0.26	1	μV/°C
dV _{OS} /dT	temperature	$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$		0.32	2	μV/°C
	L	$T_A = 25$ °C, $V_S = 2.2$ V to 5.5 V, $V_{CM} < (V^+) - 1.3$ V		5	20	μV/V
PSRR	Input offset voltage versus power supply	$T_A = -40$ °C to +125°C, $V_S = 2.2$ V to 5.5 V, $V_{CM} < (V^+) - 1.3$ V		5		μV/V
	Channel separation, dc (dual, quad)			0.5		mV/V
INPUT BIA	S CURRENT		•		·	
	land bin named	T _A = 25°C		0.2	10	pA
I _B	Input bias current	$T_A = -40$ °C to +125°C	See Typic	al Characteri	stics	pA
los	Input offset current			0.2	10	pA
NOISE						
	Input voltage noise	f = 0.1 Hz to 10 Hz		0.8		μV_{PP}
e _n	Input voltage noise density	f = 1 kHz		7.5		nV/√Hz
i _n	Input current noise	f = 1 kHz		2		fA/√Hz
INPUT VOL	LTAGE RANGE					
V _{CM}	Common-mode voltage range		(V [−]) − 0.1		(V ⁺) + 0.1	V
CMRR	Common-mode rejection ratio	$(V^-) < V_{CM} < (V^+) - 1.3 \text{ V}$	76	90		dB
INPUT CAF	PACITANCE					
	Differential			6.5		pF
	Common-mode			13		pF
OPEN-LOC	OP GAIN					
		$50 \text{ mV} < V_O < (V^+) - 50 \text{ mV}, R_L = 10 \text{ k}Ω$	120	134		dB
A _{OL}	Open-loop voltage gain	100 mV < V_O < (V^+) – 100 mV, R_L = 2 kΩ	120	126		dB
FREQUEN	CY RESPONSE C _L = 100 pF, \	1				
GBW	Gain-bandwidth product			5.5		MHz
SR	Slew rate	G = 1		2		V/µs
	0 111 11	To 0.1%, 2-V step , G = 1		1.6		μs
t _S	Settling time	To 0.01%, 2-V step , G = 1		2		μs
	Overload recovery time	V _{IN} × gain > V _S		0.33		μs
THD+N	Total harmonic distortion + noise	$V_{O} = 1 V_{RMS}, G = 1, f = 1 \text{ kHz}, R_{L} = 10 \text{ k}\Omega$	(0.00027%		

Submit Documentation Feedback

Copyright © 2007–2015, Texas Instruments Incorporated

SBOS406G -JUNE 2007-REVISED DECEMBER 2015

www.ti.com

Electrical Characteristics (continued)

At $T_A = 25$ °C, $R_L = 10$ k Ω connected to V_S / 2, $V_{CM} = V_S$ / 2, and $V_{OUT} = V_S$ / 2, unless otherwise noted.

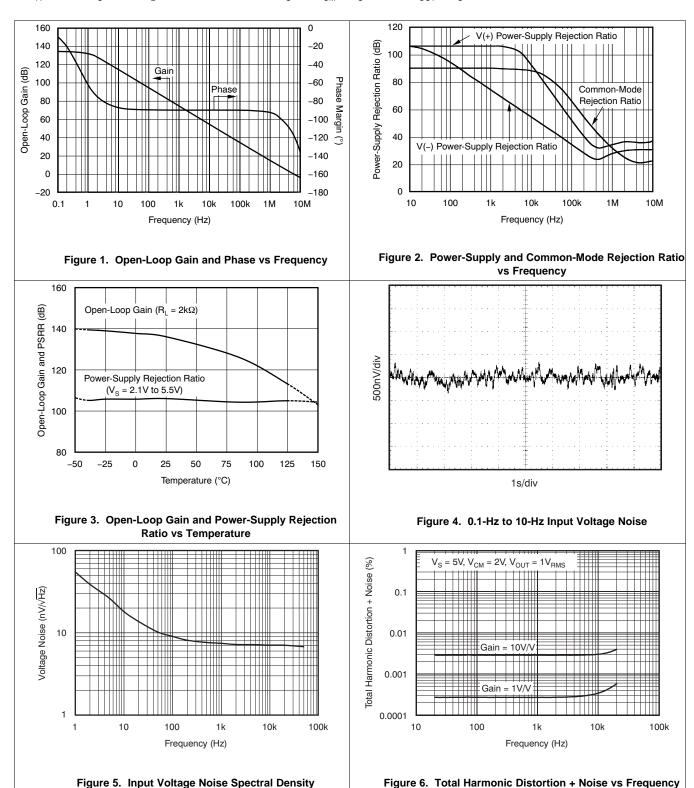
	PARAMETER	TEST	CONDITIONS	MIN	TYP	MAX	UNIT
OUTPUT							
		$T_A = 25^{\circ}C, R_L = 10 \text{ k}\Omega$	SC70-5, SOT23-5, SO-8, VSSOP-8, and TSSOP-14 packages only		10	20	mV
			DSBGA package only		20	30	mV
	Voltage output swing from	$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}, R$	L = 10 kΩ			40	mV
rail	$T_A = 25$ °C, $R_L = 2 \text{ k}\Omega$	SC70-5, SOT23-5, SO-8, VSSOP-8, and TSSOP-14 packages only		40	50	mV	
		DSBGA package only		50	60	mV	
		$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}, R$	L = 2 kΩ			80	mV
I _{SC}	Short-circuit current			+3	0, –50		mA
C _{LOAD}	Capacitive load drive			See Typical C	haracteristic	s	
R _O	Open-loop output impedance				150		Ω
POWER S	SUPPLY						
Vs	Specified voltage range			2.2		5.5	V
	Operating voltage range			2	to 5.5		V
	Quiescent current per	$T_A = 25$ °C, $I_O = 0$, $V_S = 5$.	.5 V, V _{CM} < (V ⁺) - 1.3 V		760	950	μΑ
IQ	amplifier	$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$				1	mA
TEMPERA	ATURE	•				Į.	
	Specified range			-40		125	°C
	Operating range			-40		150	°C

Product Folder Links: OPA376 OPA2376 OPA4376

www.ti.com

6.8 Typical Characteristics

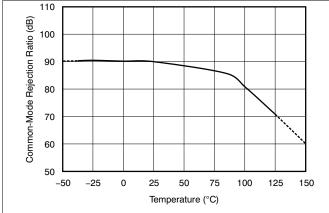
At $T_A = 25$ °C, $V_S = 5$ V, $R_L = 10$ k Ω connected to V_S / 2, $V_{CM} = V_S$ / 2, and $V_{OUT} = V_S$ / 2, unless otherwise noted.



SBOS406G –JUNE 2007–REVISED DECEMBER 2015

Typical Characteristics (continued)

At $T_A = 25$ °C, $V_S = 5$ V, $R_L = 10$ k Ω connected to V_S / 2, $V_{CM} = V_S$ / 2, and $V_{OUT} = V_S$ / 2, unless otherwise noted.



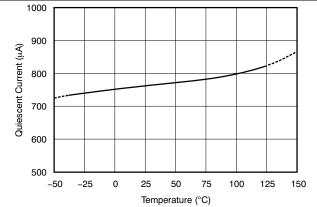
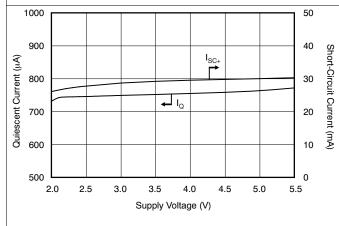


Figure 7. Common-Mode Rejection Ratio vs Temperature

Figure 8. Quiescent Current vs Temperature



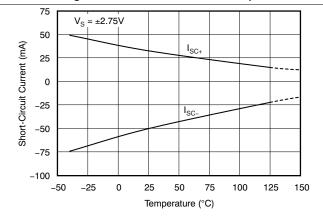
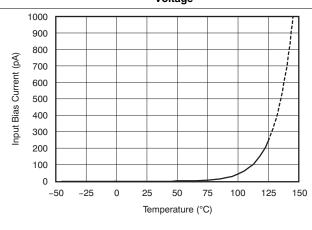


Figure 9. Quiescent and Short-Circuit Current vs Supply Voltage

Figure 10. Short-Circuit Current vs Temperature



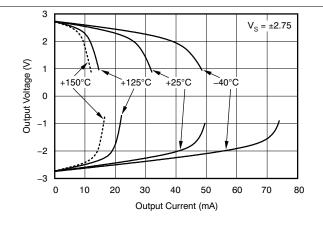


Figure 11. Input Bias Current vs Temperature

Figure 12. Output Voltage vs Output Current

NSTRUMENTS

Typical Characteristics (continued)

At $T_A = 25$ °C, $V_S = 5$ V, $R_L = 10$ k Ω connected to V_S / 2, $V_{CM} = V_S$ / 2, and $V_{OUT} = V_S$ / 2, unless otherwise noted.

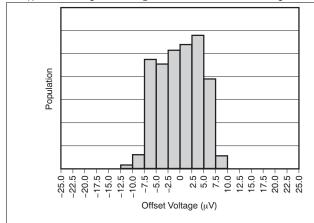


Figure 13. Offset Voltage Production Distribution

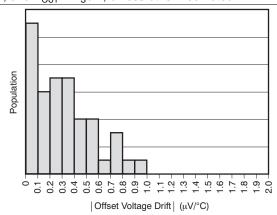


Figure 14. Offset Voltage Drift Production Distribution (-40°C to 125°C)

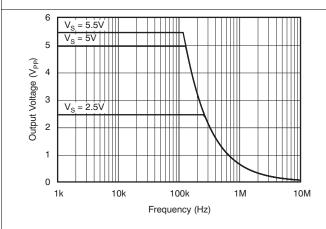


Figure 15. Maximum Output Voltage vs Frequency

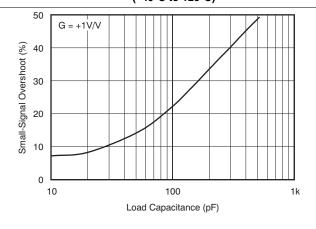


Figure 16. Small-Signal Overshoot vs Load Capacitance

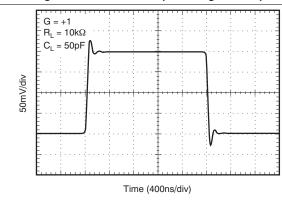


Figure 17. Small-Signal Pulse Response

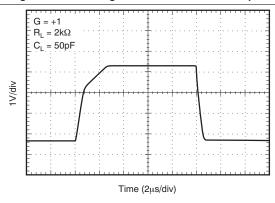


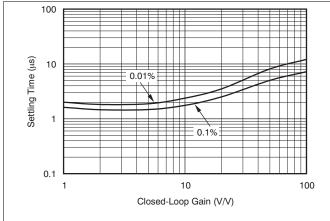
Figure 18. Large-Signal Pulse Response



SBOS406G –JUNE 2007–REVISED DECEMBER 2015

Typical Characteristics (continued)

At $T_A = 25$ °C, $V_S = 5$ V, $R_L = 10$ k Ω connected to V_S / 2, $V_{CM} = V_S$ / 2, and $V_{OUT} = V_S$ / 2, unless otherwise noted.



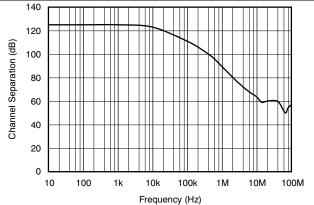


Figure 19. Settling Time vs Closed-Loop Gain

Figure 20. Channel Separation vs Frequency

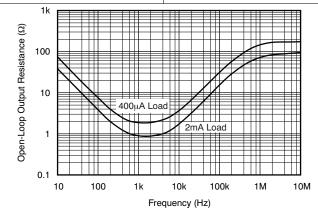


Figure 21. Open-Loop Output Resistance vs Frequency

Copyright © 2007–2015, Texas Instruments Incorporated

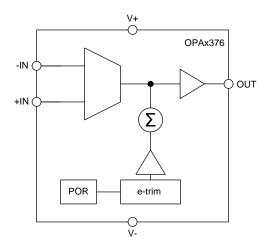
www.ti.com

7 Detailed Description

7.1 Overview

The OPA376 family belongs to a new generation of low-noise operational amplifiers with *e-trim*, giving customers outstanding dc precision and ac performance. Low noise, rail-to-rail input and output, and low offset, drawing a low quiescent current, make these devices ideal for a variety of precision and portable applications. In addition, this device has a wide supply range with excellent PSRR, making it a suitable option for applications that are battery-powered without regulation.

7.2 Functional Block Diagram



7.3 Feature Description

The OPAx376 family of precision amplifiers offers excellent dc performance as well as excellent ac performance. Operating from a single power-supply the OPAx376 is capable of driving large capacitive loads, has a wide input common-mode voltage range, and is well-suited to drive the inputs of SAR ADCs as well as 24-bit and higher resolution converters. Including internal ESD protection, the OPAx376 family is offered in a variety of industry-standard packages, including a wafer chip-scale package for applications that require space savings.

7.3.1 Operating Voltage

The OPA376 family of amplifiers operates over a power-supply range of 2.2 V to 5.5 V (±1.1 V to ±2.75 V). Many of the specifications apply from –40°C to +125°C. Parameters that can exhibit significant variance with regard to operating voltage or temperature are presented in the *Typical Characteristics*.

7.3.2 Input Offset Voltage and Input Offset Voltage Drift

The OPAx376 family of operational amplifiers is manufactured using TI's e-trim technology. Each amplifier is trimmed in production, thereby minimizing errors associated with input offset voltage and input offset voltage drift. The e-trim technology is a TI proprietary method of trimming internal device parameters during either wafer probing or final testing.

7.3.3 Capacitive Load and Stability

The OPA376 series of amplifiers may be used in applications where driving a capacitive load is required. As with all op amps, there may be specific instances where the OPAx376 can become unstable, leading to oscillation. The particular op amp circuit configuration, layout, gain, and output loading are some of the factors to consider when establishing whether an amplifier will be stable in operation. An op amp in the unity-gain (+1-V/V) buffer configuration and driving a capacitive load exhibits a greater tendency to be unstable than an amplifier operated at a higher noise gain. The capacitive load, in conjunction with the op amp output resistance, creates a pole within the feedback loop that degrades the phase margin. The degradation of the phase margin increases as the capacitive loading increases.

Submit Documentation Feedback

Copyright © 2007–2015, Texas Instruments Incorporated

SBOS406G –JUNE 2007–REVISED DECEMBER 2015

Feature Description (continued)

The OPAx376 in a unity-gain configuration can directly drive up to 250 pF of pure capacitive load. Increasing the gain enhances the ability of the amplifier to drive greater capacitive loads; see the typical characteristic Figure 16. In unity-gain configurations, capacitive load drive can be improved by inserting a small (10- Ω to 20- Ω) resistor, R_S, in series with the output, as shown in Figure 22. This resistor significantly reduces ringing while maintaining dc performance for purely capacitive loads. However, if there is a resistive load in parallel with the capacitive load, a voltage divider is created, introducing a gain error at the output and slightly reducing the output swing. The error introduced is proportional to the ratio R_S / R_L, and is generally negligible at low output current levels.

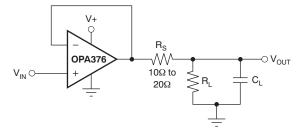


Figure 22. Improving Capacitive Load Drive

7.3.4 Common-Mode Voltage Range

The input common-mode voltage range of the OPA376 series extends 100 mV beyond the supply rails. The offset voltage of the amplifier is very low, from approximately (V^-) to (V^+) – 1 V, as shown in Figure 23. The offset voltage increases as common-mode voltage exceeds (V^+) –1 V. Common-mode rejection is specified from (V^-) to (V^+) – 1.3 V.

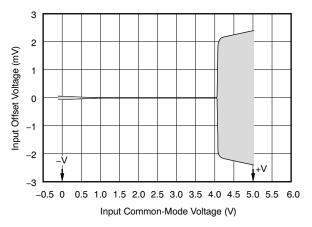


Figure 23. Offset and Common-Mode Voltage

Copyright © 2007–2015, Texas Instruments Incorporated

SBOS406G - JUNE 2007-REVISED DECEMBER 2015

www.ti.com

Feature Description (continued)

7.3.5 Input and ESD Protection

The OPA376 family incorporates internal electrostatic discharge (ESD) protection circuits on all pins. In the case of input and output pins, this protection primarily consists of current steering diodes connected between the input and power-supply pins. These ESD protection diodes also provide in-circuit, input overdrive protection, as long as the current is limited to 10 mA as stated in the Absolute Maximum Ratings. Figure 24 shows how a series input resistor may be added to the driven input to limit the input current. The added resistor contributes thermal noise at the amplifier input and its value should be kept to a minimum in noise-sensitive applications.

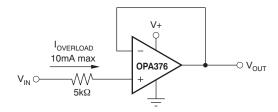


Figure 24. Input Current Protection

7.4 Device Functional Modes

The OPAx376 has a single functional mode and is operational when the power-supply voltage is greater than 2.2 V (±1.1 V). The maximum power supply voltage for the OPAx376 is 5.5 V (±2.75 V).

www.ti.com

SBOS406G -JUNE 2007-REVISED DECEMBER 2015

8 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

The OPA376 family of operational amplifiers is built using *e-trim*, a proprietary technique in which offset voltage is adjusted during the final steps of manufacturing. This technique compensates for performance shifts that can occur during the molding process. Through *e-trim*, the OPA376 family delivers excellent offset voltage (5 μ V, typical). Additionally, the amplifier boasts a fast slew rate, low drift, low noise, and excellent PSRR and A_{OL}. These 5.5-MHz CMOS op amps operate on 760- μ A (typical) quiescent current.

8.1.1 Basic Amplifier Configurations

The OPA376 family is unity-gain stable. It does not exhibit output phase inversion when the input is overdriven. A typical single-supply connection is shown in Figure 25. The OPA376 is configured as a basic inverting amplifier with a gain of -10 V/V. This single-supply connection has an output centered on the common-mode voltage, V_{CM} . For the circuit shown, this voltage is 2.5 V, but may be any value within the common-mode input voltage range.

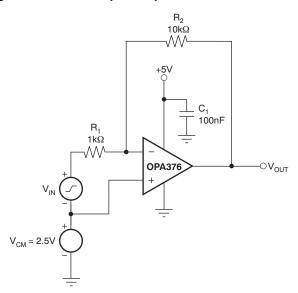


Figure 25. Basic Single-Supply Connection



Application Information (continued)

8.1.2 Active Filtering

The OPA376 series is well-suited for filter applications requiring a wide bandwidth, fast slew rate, low-noise, single-supply operational amplifier. Figure 26 shows a 50-kHz, 2nd-order, low-pass filter. The components have been selected to provide a maximally-flat Butterworth response. Beyond the cutoff frequency, roll-off is –40 dB/decade. The Butterworth response is ideal for applications requiring predictable gain characteristics such as the anti-aliasing filter used ahead of an analog-to-digital converter (ADC).

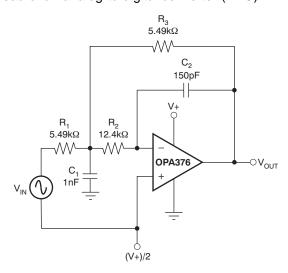
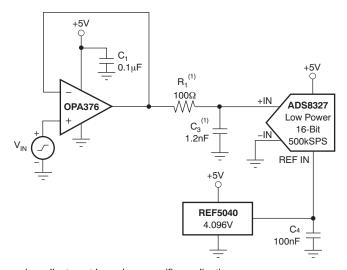


Figure 26. Second-Order, Butterworth, 50-kHz, Low-Pass Filter

8.1.3 Driving an Analog-to-Digital Converter

The low noise and wide gain bandwidth of the OPA376 family make it an ideal driver for ADCs. Figure 27 illustrates the OPA376 driving an ADS8327, a 16-bit, 250-kSPS converter. The amplifier is connected as a unitygain, non-inverting buffer.



(1) Suggested value; may require adjustment based on specific application.

Figure 27. Driving an ADS8327

SBOS406G - JUNE 2007 - REVISED DECEMBER 2015

Application Information (continued)

8.1.4 Phantom-Powered Microphone

The circuit shown in Figure 28 depicts how a remote microphone amplifier can be powered by a phantom source on the output side of the signal cable. The cable serves double duty, carrying both the differential output signal from and dc power to the microphone amplifier stage.

An OPA2376 serves as a single-ended input to a differential output amplifier with a 6-dB gain. Common-mode bias for the two op amps is provided by the dc voltage developed across the electret microphone element. A 48-V phantom supply is reduced to 5.1 V by the series 6.8-k Ω resistors on the output side of the cable, and the 4.7-k Ω resistor and zener diode on the input side of the cable. AC coupling blocks the different dc voltage levels from each other on each end of the cable.

An INA163 instrumentation amplifier provides differential inputs and receives the balanced audio signals from the cable. The INA163 gain may be set from 0 dB to 80 dB by selecting the $R_{\rm G}$ value. The INA163 circuit is typical of the input circuitry used in mixing consoles.

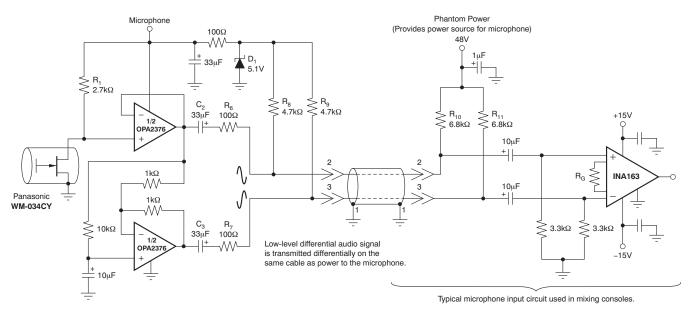
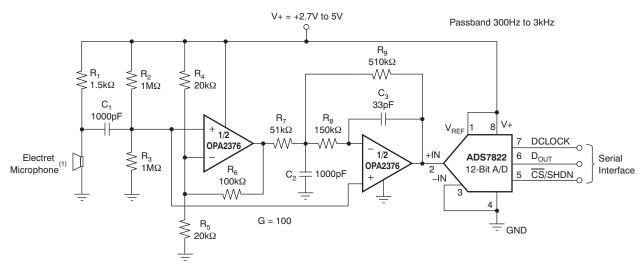


Figure 28. Phantom-Powered Electret Microphone



(1) Electret microphone powered by R₁.

Figure 29. OPA2376 as a Speech Bandpass-Filtered, Data Acquisition System

www.ti.com

8.2 Typical Application

Low-pass filters are commonly employed in signal processing applications to reduce noise and prevent aliasing. The OPA376 is ideally suited to construct high-speed, high-precision active filters. Figure 30 shows a second-order, low-pass filter commonly encountered in signal processing applications.

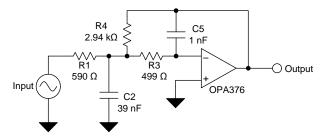


Figure 30. Typical Application Schematic

8.2.1 Design Requirements

Use the following parameters for this design example:

- Gain = 5 V/V (inverting gain)
- Low-pass cutoff frequency = 25 kHz
- Second-order Chebyshev filter response with 3-dB gain peaking in the passband

8.2.1.1 Detailed Design Procedure

The infinite-gain multiple-feedback circuit for a low-pass network function is shown in Figure 30. Use Equation 1 to calculate the voltage transfer function.

$$\frac{\text{Output}}{\text{Input}}(s) = \frac{-1/R_1R_3C_2C_5}{s^2 + (s/C_2)(1/R_1 + 1/R_3 + 1/R_4) + 1/R_3R_4C_2C_5}$$
(1)

This circuit produces a signal inversion. For this circuit, the gain at dc and the low-pass cutoff frequency are calculated by Equation 2:

Gain =
$$\frac{R_4}{R_1}$$

 $f_C = \frac{1}{2\pi} \sqrt{(1/R_3 R_4 C_2 C_5)}$ (2)

Software tools are readily available to simplify filter design. WEBENCH® Filter Designer is a simple, powerful, and easy-to-use active filter design program. The WEBENCH Filter Designer lets you create optimized filter designs using a selection of TI operational amplifiers and passive components from TI's vendor partners.

Available as a web based tool from the WEBENCH® Design Center, WEBENCH® Filter Designer allows you to design, optimize, and simulate complete multistage active filter solutions within minutes.

SBOS406G -JUNE 2007-REVISED DECEMBER 2015

Typical Application (continued)

8.2.2 Application Curve

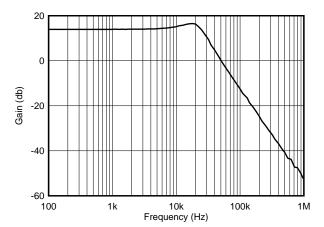


Figure 31. Low-Pass Filter Transfer Function

9 Power Supply Recommendations

The OPAx376 are specified for operation from 2.2 V to 5.5 V (±1.1 V to ±2.75 V); many specifications apply from –40°C to +125°C. Parameters that can exhibit significant variance with regard to operating voltage or temperature are presented in the *Typical Characteristics*.

10 Layout

10.1 Layout Guidelines

For best operational performance of the device, use good PCB layout practices, including:

- Noise can propagate into analog circuitry through the power pins of the circuit as a whole, and the op amp itself. Bypass capacitors can reduce the coupled noise by providing low-impedance power sources local to the analog circuitry.
 - Connect low-ESR, 0.1-µF ceramic bypass capacitors between each supply pin and ground, placed as close to the device as possible. A single bypass capacitor from V+ to ground is applicable for singlesupply applications.
- Separate grounding for analog and digital portions of circuitry is one of the simplest and most effective
 methods of noise suppression. One or more layers on multilayer PCBs are usually devoted to ground
 planes. A ground plane helps distribute heat, and reduces EMI noise pickup. Physically separate the
 digital and analog grounds, paying attention to the flow of the ground current. For more detailed
 information refer to Circuit Board Layout Techniques, SLOA089.
- To reduce parasitic coupling, run the input traces as far away from the supply or output traces as possible. If these traces cannot be kept separate, crossing the sensitive trace perpendicular is better than opposed to in parallel with the noisy trace.
- Place the external components as close to the device as possible. As shown in Figure 32, keeping RF and RG close to the inverting input minimizes parasitic capacitance.
- Keep the length of the input traces as short as possible. The input traces are the most sensitive part of the circuit.
- Consider a driven, low-impedance guard ring around the critical traces. A guard ring can significantly reduce leakage currents from nearby traces that are at different potentials.
- Clean the PCB following board assembly for best performance.
- Any precision-integrated circuit may experience performance shifts due to moisture ingress into the
 plastic package. Following any aqueous PCB cleaning process, bake the PCB assembly to remove
 moisture introduced into the device packaging during the cleaning process. A low-temperature, postcleaning bake at 85°C for 30 minutes is sufficient for most circumstances.

Copyright © 2007–2015, Texas Instruments Incorporated

www.ti.com

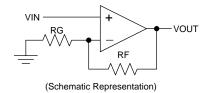
Layout Guidelines (continued)

SBOS406G - JUNE 2007-REVISED DECEMBER 2015

10.1.1 Photosensitivity

Although the OPA2376YZD package has a protective backside coating that reduces the amount of light exposure on the die, unless fully shielded, ambient light can reach the active region of the device. Input bias current for the package is specified in the absence of light. Depending on the amount of light exposure in a given application, an increase in bias current, and possible increases in offset voltage, should be expected. Fluorescent lighting may introduce noise or hum because of the time-varying light output. Best layout practices include end-product packaging that provides shielding from possible light sources during operation.

10.2 Layout Example



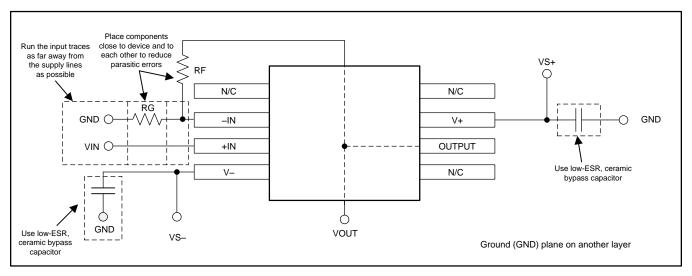


Figure 32. Layout Example

SBOS406G -JUNE 2007-REVISED DECEMBER 2015

www.ti.com

11 Device and Documentation Support

11.1 Device Support

11.1.1 Development Support

11.1.1.1 TINA-TI™ (Free Software Download)

TINA™ is a simple, powerful, and easy-to-use circuit simulation program based on a SPICE engine. TINA-TI™ is a free, fully-functional version of the TINA software, preloaded with a library of macro models in addition to a range of both passive and active models. TINA-TI provides all the conventional dc, transient, and frequency domain analysis of SPICE, as well as additional design capabilities.

Available as a free download from the Analog eLab Design Center, TINA-TI offers extensive post-processing capability that allows users to format results in a variety of ways. Virtual instruments offer the ability to select input waveforms and probe circuit nodes, voltages, and waveforms, creating a dynamic quick-start tool.

NOTE

These files require that either the TINA software (from DesignSoft™) or TINA-TI software be installed. Download the free TINA-TI software from the TINA-TI folder.

11.1.1.2 TI Precision Designs

TI Precision Designs are analog solutions created by TI's precision analog applications experts and offer the theory of operation, component selection, simulation, complete PCB schematic and layout, bill of materials, and measured performance of many useful circuits. TI Precision Designs are available online at http://www.ti.com/ww/en/analog/precision-designs/.

11.1.1.3 WEBENCH® Filter Designer

WEBENCH® Filter Designer is a simple, powerful, and easy-to-use active filter design program. The WEBENCH Filter Designer lets you create optimized filter designs using a selection of TI operational amplifiers and passive components from TI's vendor partners.

Available as a web-based tool from the WEBENCH® Design Center, WEBENCH® Filter Designer allows you to design, optimize, and simulate complete multistage active filter solutions within minutes.

11.2 Related Documentation

For related documentation, see the following:

Circuit Board Layout Techniques, SLOA089.

Operational Amplifier Gain stability, Part 3: AC Gain-Error Analysis, SLYT383.

Operational Amplifier Gain Stability, Part 2: DC Gain-Error Analysis, SLYT374.

Using infinite-gain, MFB filter topology in fully differential active filters, SLYT343.

Op Amp Performance Analysis, SBOS054.

Single-Supply Operation of Operational Amplifiers, SBOA059.

Tuning in Amplifiers, SBOA067.

Shelf-Life Evaluation of Lead-Free Component Finishes, SZZA046.

Copyright © 2007–2015, Texas Instruments Incorporated

www.ti.com

11.3 Related Links

See Table 1 for a list of quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 1. Related Links

PARTS	PRODUCT FOLDER	SAMPLE AND BUY	TECHNICAL DOCUMENTS	TOOLS AND SOFTWARE	SUPPORT AND COMMUNITY
OPA376	Click here	Click here	Click here	Click here	Click here
OPA2376	Click here	Click here	Click here	Click here	Click here
OPA4376	Click here	Click here	Click here	Click here	Click here

11.4 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

11.5 Trademarks

e-trim, TINA-TI, E2E, NanoStar, NanoFree are trademarks of Texas Instruments.

TINA, DesignSoft are trademarks of DesignSoft, Inc.

All other trademarks are the property of their respective owners.

11.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

11.7 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

SBOS406G - JUNE 2007 - REVISED DECEMBER 2015

www.ti.com

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

The OPAx376 are specified for operation from 2.2 V to 5.5 V (±1.1 V to ±2.75 V); many specifications apply from -40°C to +125°C. Parameters that can exhibit significant variance with regard to operating voltage or temperature are presented in the *Typical Characteristics*.

The OPA2376YZD is a lead (Pb)-free, die-level, die-size ball grid array (DSBGA) package. Unlike devices that are in plastic packages, these devices have no molding compound, lead frame, wire bonds, or leads. Using standard surface-mount assembly procedures, the DSBGA can be mounted to a printed circuit board (PCB) without additional underfill. Figure 33 and Figure 34 detail the pinout and package marking. See Application Note SBVA017, NanoStarTM and NanoFreeTM 300 μ m Solder Bump WCSP, for more detailed information on package characteristics and PCB design.

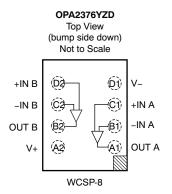


Figure 33. Pin Description

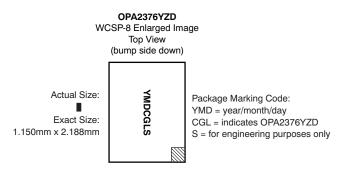


Figure 34. Top-View Package Marking



PACKAGE OPTION ADDENDUM

www.ti.com 29-Dec-2024

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
OPA2376AID	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA 2376	Samples
OPA2376AIDGKR	ACTIVE	VSSOP	DGK	8	2500	RoHS & Green	Call TI SN NIPDAUAG	Level-2-260C-1 YEAR	-40 to 125	OBBI	Samples
OPA2376AIDGKRG4	ACTIVE	VSSOP	DGK	8	2500	RoHS & Green	Call TI NIPDAUAG	Level-2-260C-1 YEAR	-40 to 125	OBBI	Samples
OPA2376AIDGKT	ACTIVE	VSSOP	DGK	8	250	RoHS & Green	Call TI SN NIPDAUAG	Level-2-260C-1 YEAR	-40 to 125	OBBI	Samples
OPA2376AIDR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA 2376	Samples
OPA2376AIDRG4	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA 2376	Samples
OPA2376AIYZDR	ACTIVE	DSBGA	YZD	8	3000	RoHS & Green	SNAGCU	Level-1-260C-UNLIM	-40 to 125	OPA2376	Samples
OPA2376AIYZDT	ACTIVE	DSBGA	YZD	8	250	RoHS & Green	SNAGCU	Level-1-260C-UNLIM	-40 to 125	OPA2376	Samples
OPA376AID	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA 376	Samples
OPA376AIDBVR	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	BUQ	Samples
OPA376AIDBVRG4	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	BUQ	Samples
OPA376AIDBVT	ACTIVE	SOT-23	DBV	5	250	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	BUQ	Samples
OPA376AIDBVTG4	ACTIVE	SOT-23	DBV	5	250	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	BUQ	Samples
OPA376AIDCKR	ACTIVE	SC70	DCK	5	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	BUR	Samples
OPA376AIDCKRG4	ACTIVE	SC70	DCK	5	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	BUR	Samples
OPA376AIDCKT	ACTIVE	SC70	DCK	5	250	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	BUR	Samples
OPA376AIDCKTG4	ACTIVE	SC70	DCK	5	250	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	BUR	Samples
OPA376AIDR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA 376	Samples
OPA376AIDRG4	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA 376	Samples





PACKAGE OPTION ADDENDUM

www.ti.com 29-Dec-2024

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
OPA4376AIPW	ACTIVE	TSSOP	PW	14	90	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4376	Samples
OPA4376AIPWR	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4376	Samples
OPA4376AIPWRG4	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4376	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

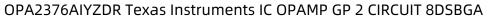
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.





PACKAGE OPTION ADDENDUM

www.ti.com 29-Dec-2024

OTHER QUALIFIED VERSIONS OF OPA2376, OPA376, OPA4376:

• Automotive : OPA2376-Q1, OPA376-Q1, OPA4376-Q1

NOTE: Qualified Version Definitions:

• Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects



PACKAGE MATERIALS INFORMATION

www.ti.com 18-Nov-2024

TAPE AND REEL INFORMATION





	-
A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
OPA2376AIDGKR	VSSOP	DGK	8	2500	330.0	12.4	5.25	3.35	1.25	8.0	12.0	Q1
OPA2376AIDGKRG4	VSSOP	DGK	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
OPA2376AIDGKT	VSSOP	DGK	8	250	330.0	12.4	5.25	3.35	1.25	8.0	12.0	Q1
OPA2376AIDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
OPA2376AIYZDR	DSBGA	YZD	8	3000	180.0	8.4	1.24	2.29	0.81	4.0	8.0	Q1
OPA2376AIYZDT	DSBGA	YZD	8	250	180.0	8.4	1.24	2.29	0.81	4.0	8.0	Q1
OPA376AIDBVR	SOT-23	DBV	5	3000	179.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
OPA376AIDBVR	SOT-23	DBV	5	3000	180.0	8.4	3.23	3.17	1.37	4.0	8.0	Q3
OPA376AIDBVT	SOT-23	DBV	5	250	180.0	8.4	3.23	3.17	1.37	4.0	8.0	Q3
OPA376AIDBVT	SOT-23	DBV	5	250	179.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
OPA376AIDCKR	SC70	DCK	5	3000	178.0	9.0	2.4	2.5	1.2	4.0	8.0	Q3
OPA376AIDCKT	SC70	DCK	5	250	178.0	9.0	2.4	2.5	1.2	4.0	8.0	Q3
OPA376AIDCKT	SC70	DCK	5	250	179.0	8.4	2.2	2.5	1.2	4.0	8.0	Q3
OPA376AIDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
OPA4376AIPWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



PACKAGE MATERIALS INFORMATION

www.ti.com 18-Nov-2024



*All dimensions are nominal

All diffierisions are nominal	1	1					
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
OPA2376AIDGKR	VSSOP	DGK	8	2500	366.0	364.0	50.0
OPA2376AIDGKRG4	VSSOP	DGK	8	2500	366.0	364.0	50.0
OPA2376AIDGKT	VSSOP	DGK	8	250	366.0	364.0	50.0
OPA2376AIDR	SOIC	D	8	2500	356.0	356.0	35.0
OPA2376AIYZDR	DSBGA	YZD	8	3000	182.0	182.0	20.0
OPA2376AIYZDT	DSBGA	YZD	8	250	182.0	182.0	20.0
OPA376AIDBVR	SOT-23	DBV	5	3000	213.0	191.0	35.0
OPA376AIDBVR	SOT-23	DBV	5	3000	202.0	201.0	28.0
OPA376AIDBVT	SOT-23	DBV	5	250	223.0	270.0	35.0
OPA376AIDBVT	SOT-23	DBV	5	250	213.0	191.0	35.0
OPA376AIDCKR	SC70	DCK	5	3000	180.0	180.0	18.0
OPA376AIDCKT	SC70	DCK	5	250	180.0	180.0	18.0
OPA376AIDCKT	SC70	DCK	5	250	213.0	191.0	35.0
OPA376AIDR	SOIC	D	8	2500	356.0	356.0	35.0
OPA4376AIPWR	TSSOP	PW	14	2000	356.0	356.0	35.0



PACKAGE MATERIALS INFORMATION

www.ti.com 18-Nov-2024

TUBE



*All dimensions are nominal

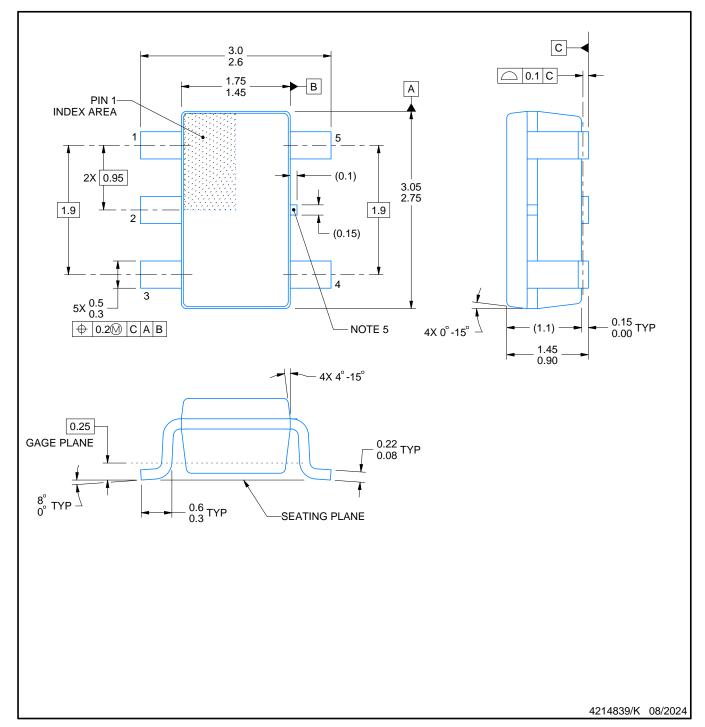
Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
OPA2376AID	D	SOIC	8	75	506.6	8	3940	4.32
OPA376AID	D	SOIC	8	75	506.6	8	3940	4.32
OPA4376AIPW	PW	TSSOP	14	90	508	8.5	3250	2.8



PACKAGE OUTLINE

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES:

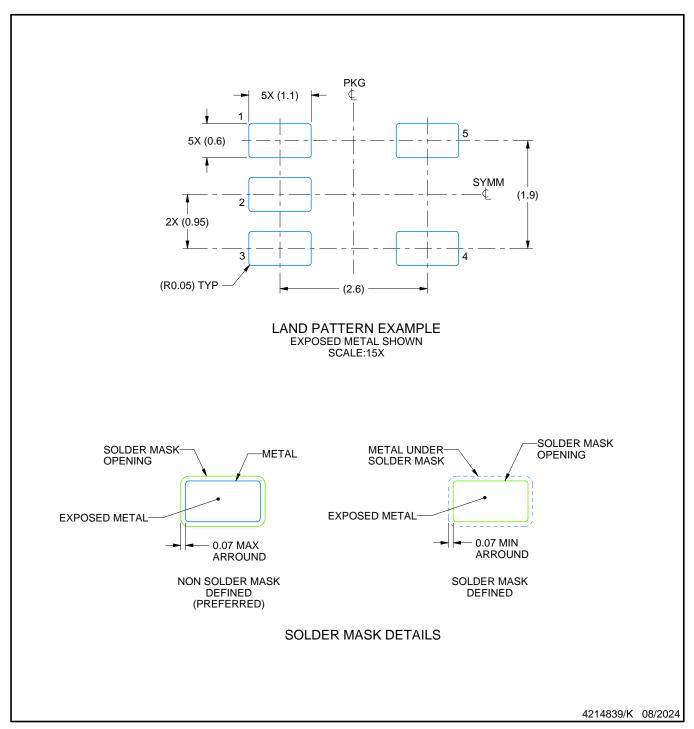
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 2. This drawing is subject to change without notice.
 3. Refernce JEDEC MO-178.

DBV0005A

- 4. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25 mm per side.
- 5. Support pin may differ or may not be present.



SMALL OUTLINE TRANSISTOR



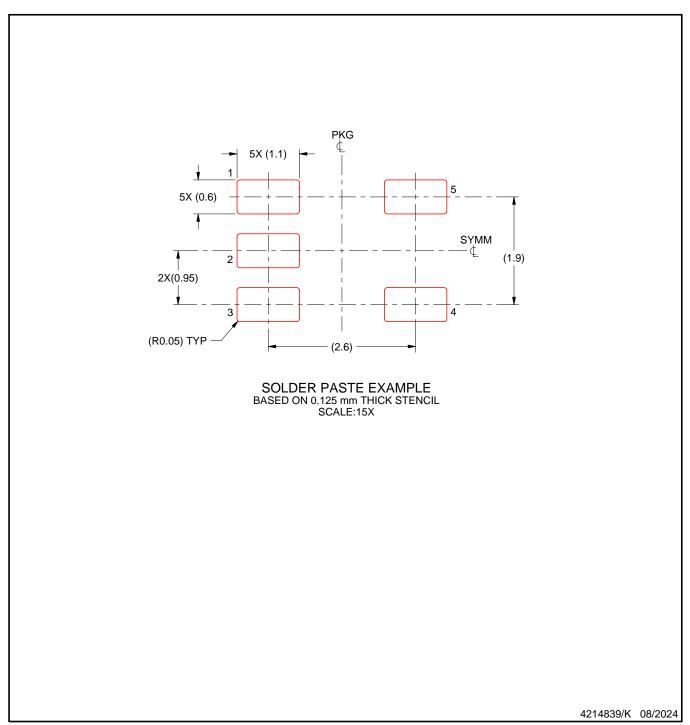
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE TRANSISTOR



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



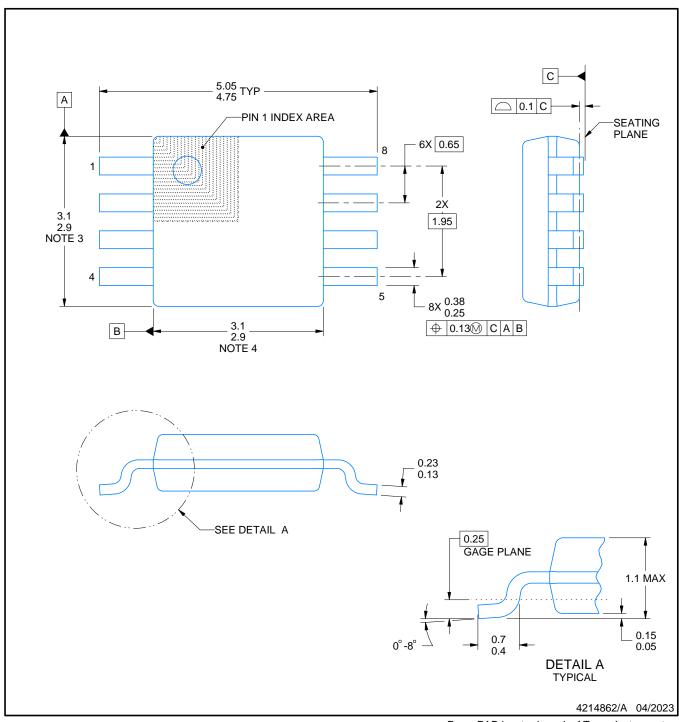
PACKAGE OUTLINE

VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



DGK0008A



NOTES:

PowerPAD is a trademark of Texas Instruments.

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-187.

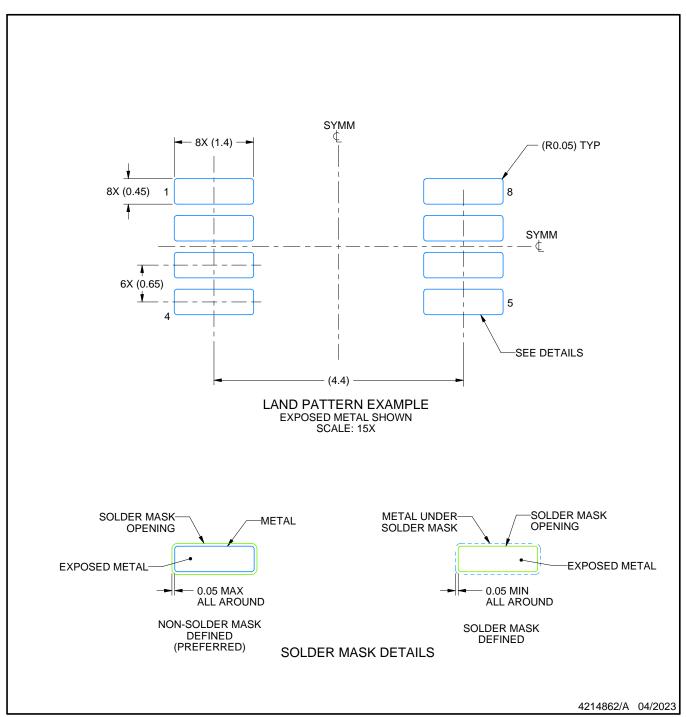


EXAMPLE BOARD LAYOUT

DGK0008A

[™] VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
- 8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
- 9. Size of metal pad may vary due to creepage requirement.

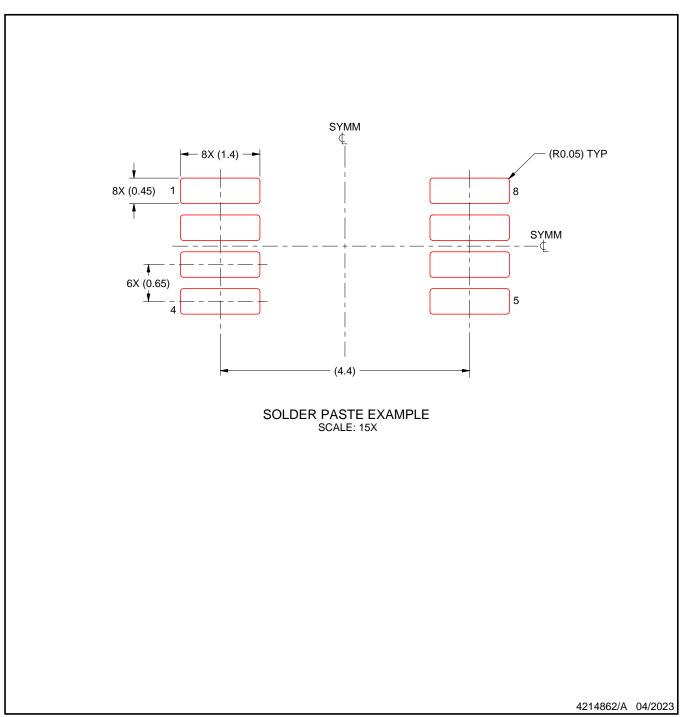


EXAMPLE STENCIL DESIGN

DGK0008A

™ VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



- 11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 12. Board assembly site may have different recommendations for stencil design.

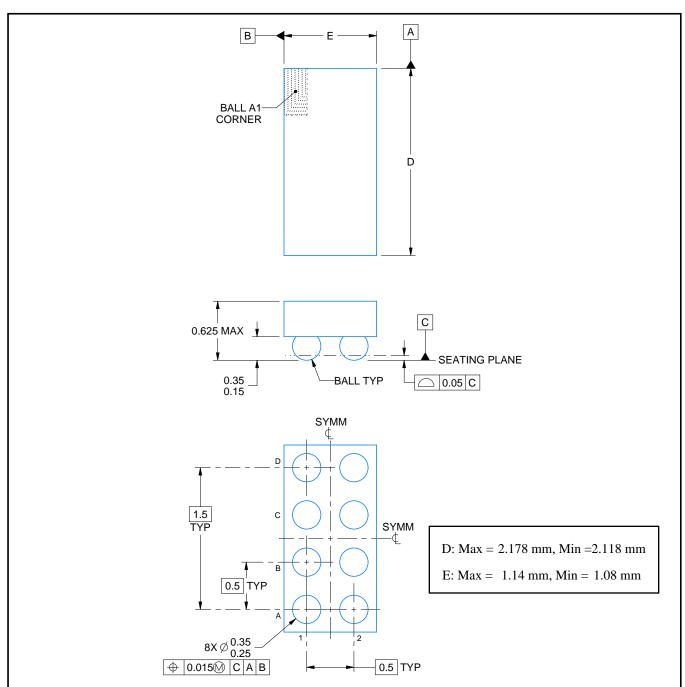


DSBGA - 0.625 mm max height

PACKAGE OUTLINE

DIE SIZE BALL GRID ARRAY

4219545/A 12/2018



NOTES:

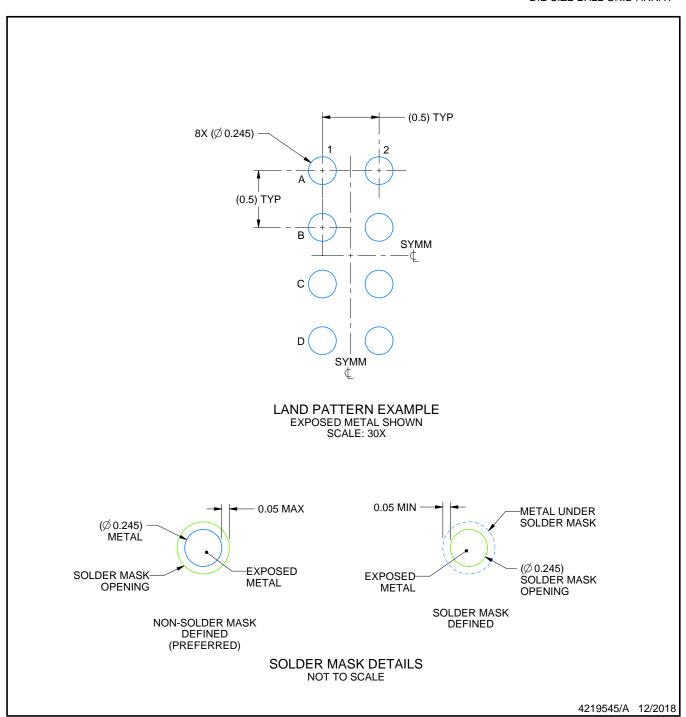
YZD0008

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.



DIE SIZE BALL GRID ARRAY

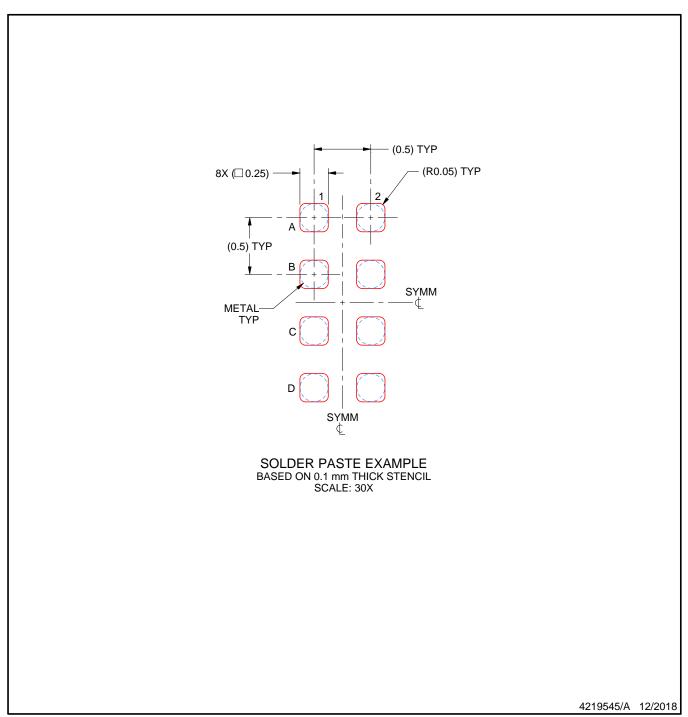


NOTES: (continued)

3. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. See Texas Instruments Literature No. SNVA009 (www.ti.com/lit/snva009).



DIE SIZE BALL GRID ARRAY



NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.



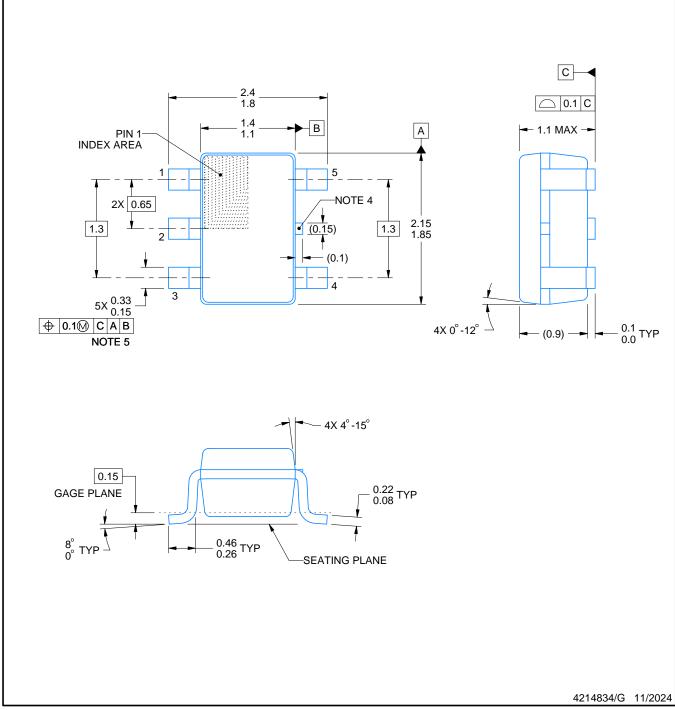


SOT - 1.1 max height

PACKAGE OUTLINE

SMALL OUTLINE TRANSISTOR





NOTES:

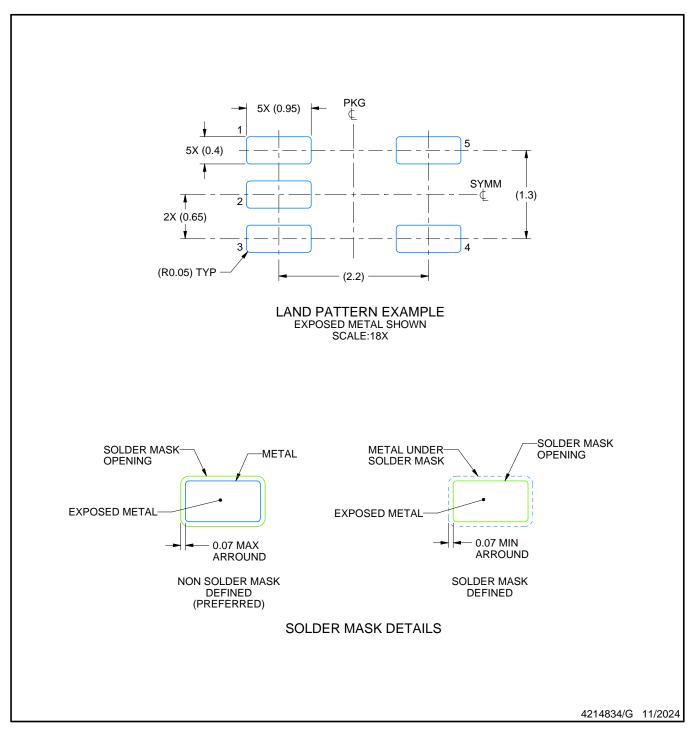
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 2. This drawing is subject to change without notice.
 3. Refernce JEDEC MO-203.

DCK0005A

- 4. Support pin may differ or may not be present.
- 5. Lead width does not comply with JEDEC.
- 6. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25mm per side



SMALL OUTLINE TRANSISTOR



- 7. Publication IPC-7351 may have alternate designs.
- 8. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

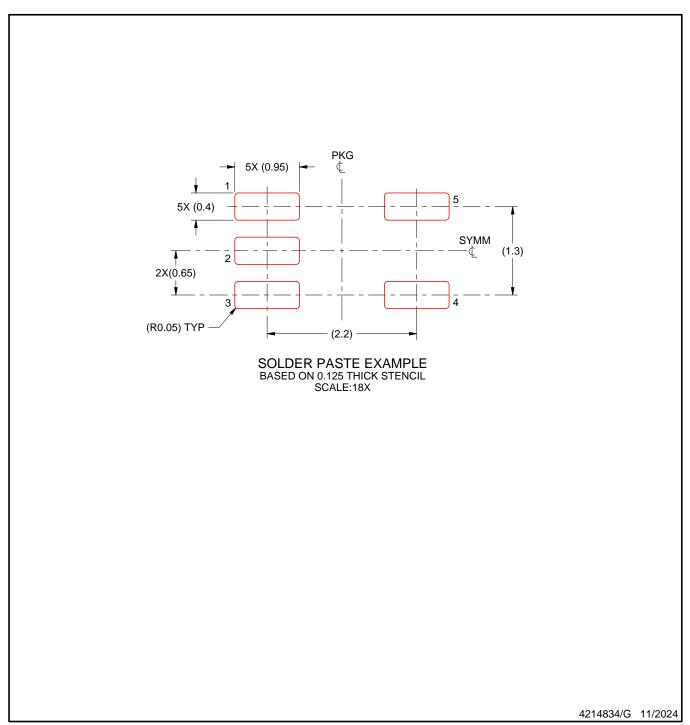


EXAMPLE STENCIL DESIGN

DCK0005A

SOT - 1.1 max height

SMALL OUTLINE TRANSISTOR



- 9. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 10. Board assembly site may have different recommendations for stencil design.

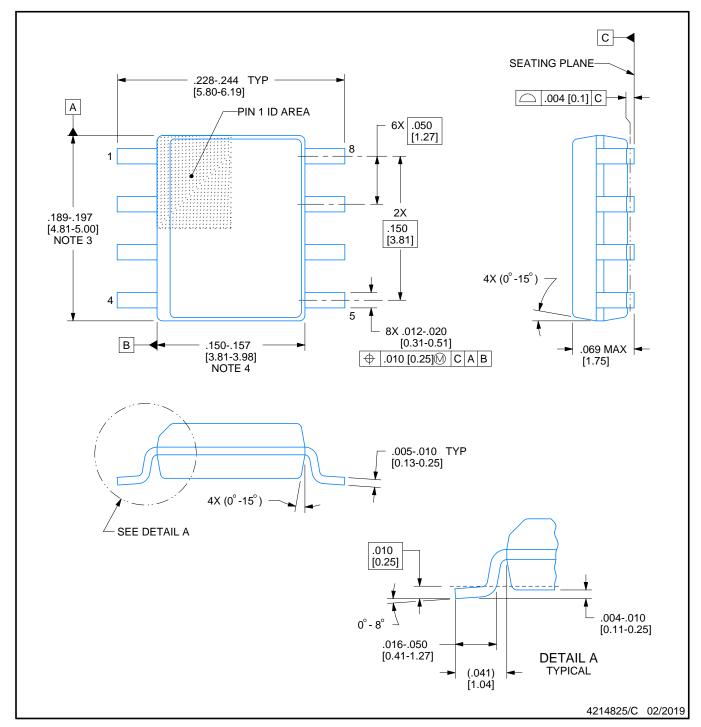




PACKAGE OUTLINE

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



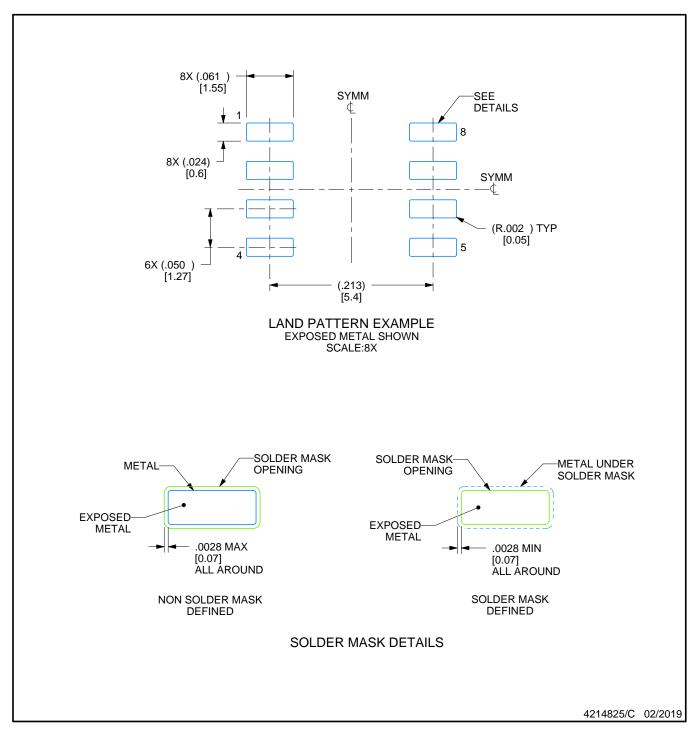
NOTES:

D0008A

- 1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.



SMALL OUTLINE INTEGRATED CIRCUIT



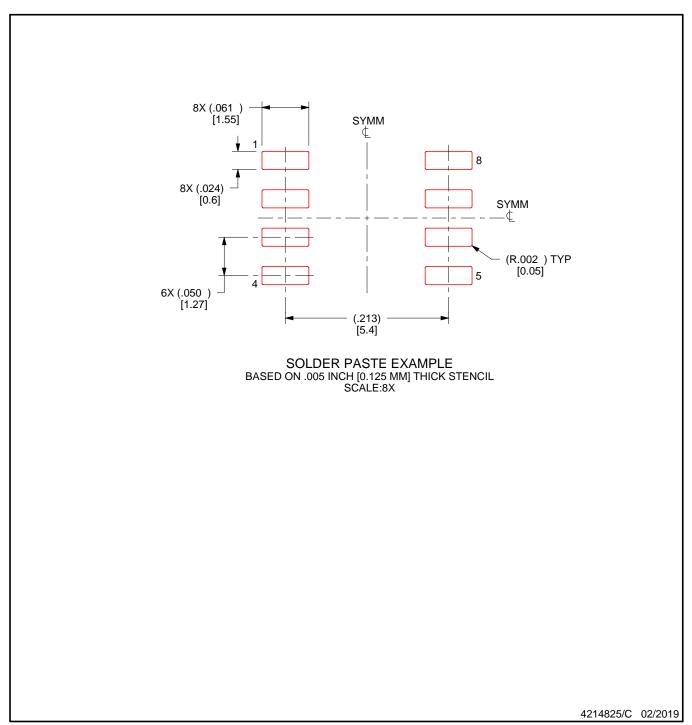
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE INTEGRATED CIRCUIT



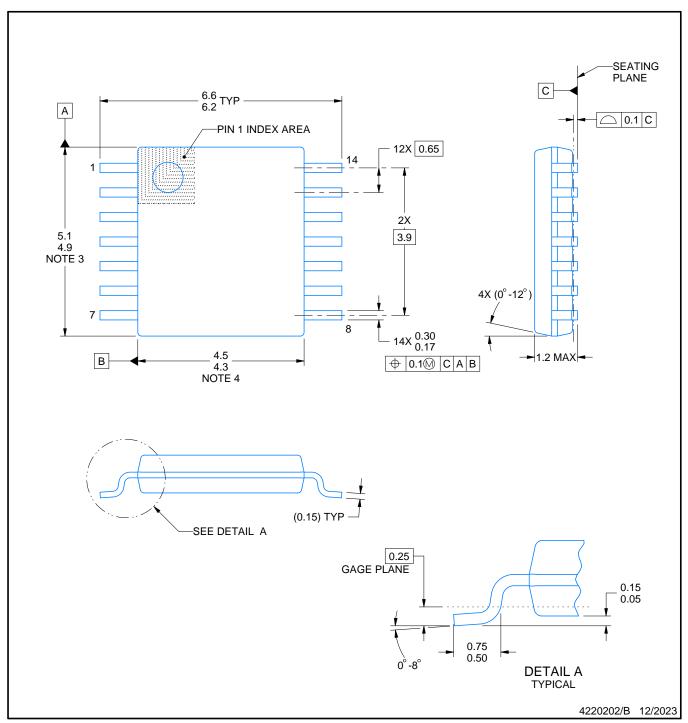
- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.





TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



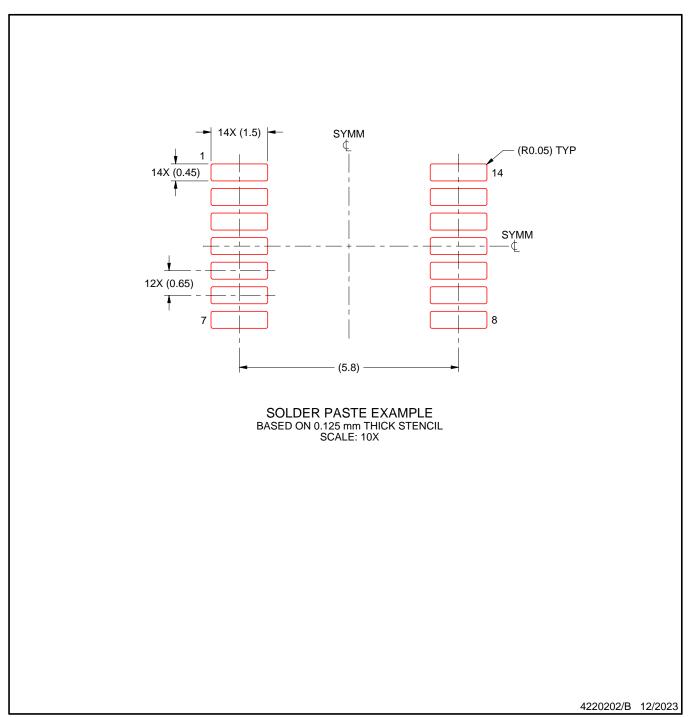
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2025. Texas Instruments Incorporated



OUR CERTIFICATE

DiGi provide top-quality products and perfect service for customer worldwide through standardization, technological innovation and continuous improvement. DiGi through third-party certification, we striciy control the quality of products and services. Welcome your RFQ to Email: Info@DiGi-Electronics.com

















Tel: +00 852-30501935

RFQ Email: Info@DiGi-Electronics.com